

ECOSPARK® Ignition IGBT 500 mJ, 450 V, N-Channel Ignition IGBT ISL9V5045S3ST-F085C

Features

- SCIS Energy = 500 mJ at $T_J = 25^{\circ}\text{C}$
- Logic Level Gate Drive
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Applications

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Collector to Emitter Breakdown Voltage (I _C = 1 mA)	BV _{CER}	480	V
Emitter to Collector Voltage – Reverse Battery Condition (I _C = 10 mA)	BV _{ECS}	24	٧
I_{SCIS} = 39.2 A, L = 650 μHy, R _{GE} = 1 kΩ, T _C = 25°C (Note 1)	E _{SCIS25}	500	mJ
I_{SCIS} = 31.1 A, L = 650 μHy, R _{GE} = 1 kΩ, T _C = 150°C (Note 2)	E _{SCIS150}	315	mJ
Collector Current Continuous, at V _{GE} = 4.0 V, T _C = 25°C	IC25	51	Α
Collector Current Continuous, at V_{GE} = 4.0 V, T_{C} = 110°C	IC110	43	Α
Gate to Emitter Voltage Continuous	V_{GEM}	±10	V
Power Dissipation Total, T _C = 25°C	PD	300	W
Power Dissipation Derating, T _C > 25°C	PD	2	W/°C
Operating Junction and Storage Temperature	T _J , T _{STG}	-40 to 175	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	300	°C
Reflow soldering according to JESD020C	T _{PKG}	260	°C
HBM–Electrostatic Discharge Voltage at 100 pF, 1500 Ω	ESD	4	kV
CDM–Electrostatic Discharge Voltage at 1 Ω	ESD	2	kV

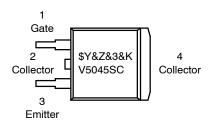
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Self Clamped inductive Switching Energy (ESCIS25) of 500 mJ is based on the test conditions that is starting $T_J = 25^{\circ}C$, $L = 650 \,\mu\text{Hy}$, $I_{SCIS} = 39.2 \,\text{A}$, V_{CC} = 100 V during inductor charging and V_{CC} = 0 V during time in clamp. 2. Self Clamped inductive Switching Energy (ESCIS150) of 315 mJ is based on
- the test conditions that is starting $T_J = 150$ °C, $L = 650 \mu Hy$, $I_{SCIS} = 31.1 A$, V_{CC} = 100 V during inductor charging and V_{CC} =0 V during time in clamp.

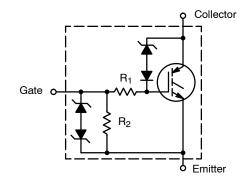


D²PAK-3 CASE 418AJ

MARKING DIAGRAM



= ON Semiconductor Logo &Z = Assembly Plant Code &3 = Date Code (Week & Year) &K = Lot Code V5045SC = Specific Device Code



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case - Steady State (Drain)	$R_{ heta JC}$	0.9	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•	•
Collector to Emitter Breakdown Voltage	BV _{CER}	I_{CE} = 2 mA, V_{GE} = 0 V, R_{GE} = 1 k Ω , T_{J} = -40 to 150°C		420	450	480	V
Collector to Emitter Breakdown Voltage	BV _{CES}	I_{CE} = 10 mA, V_{GE} = 0 V, R_{GE} = 0 Ω , T_{J} = -40 to 150°C		445	475	505	V
Emitter to Collector Breakdown Voltage	BV _{ECS}	I_{CE} = -75 mA, V_{GE} = 0 V, T_{J} = 25°C		30	-	_	V
Gate to Emitter Breakdown Voltage	BV _{GES}	$I_{GES} = \pm 2 \text{ mA}$		±12	±14	-	V
Collector to Emitter Leakage	I _{CER}	V_{CE} = 175 V, R_{GE} = 1 k Ω	T _J = 25°C	-	_	25	μΑ
Current			T _J = 150°C	-	_	1	mA
Emitter to Collector Leakage	I _{ECS}	V _{EC} = 24 V	T _J = 25°C	-	_	1	mA
Current			T _J = 150°C	-	_	40	1
Series Gate Resistance	R ₁			-	100	_	Ω
Gate to Emitter Resistance	R ₂			10	_	30	kΩ
ON CHARACTERISTICS				-			
Collector to Emitter Saturation Voltage	V _{CE(SAT)}	I_{CE} = 10 A, V_{GE} = 4.0 V, T_{J} = 25°C		-	1.25	1.6	٧
Collector to Emitter Saturation Voltage	V _{CE(SAT)}	I _{CE} = 15 A, V _{GE} = 4.5 V, T _J = 150°C		-	1.47	1.8	V
DYNAMIC CHARACTERISTICS							
Gate Charge	$Q_{G(ON)}$	I _{CE} = 10 A, V _{CE} = 12 V, V _{GE} = 5 V		_	32	-	nC
Gate to Emitter Threshold	V _{GE(TH)}	I _{CE} = 1 mA, V _{CE} = V _{GE}	T _J = 25°C	1.3	_	2.2	V
Voltage			T _J = 150°C	0.75	-	1.8	
Gate to Emitter Plateau Voltage	V_{GEP}	V _{CE} = 12 V, I _{CE} = 12 A		-	3.1	-	V
SWITCHING CHARACTERISTIC							
	cs						
Current Turn-On Delay Time-Resistive	td _{(ON)R}	$V_{CE} = 14 \text{ V}, R_{L} = 1 \Omega, V_{GE} = T_{J} = 25^{\circ}\text{C}$	5 V, R _G = 1 kΩ,	-	0.7	4	μs
			5 V, R _G = 1 kΩ,	-	0.7 2.1	7	μs
Time-Resistive	td _{(ON)R}						μs

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Device	Package	Shipping [†]
ISL9V5045S3ST-F085C	D ² PAK-3 (Pb-Free)	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

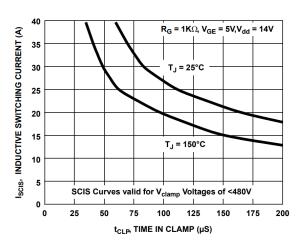


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

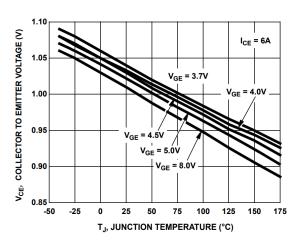


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

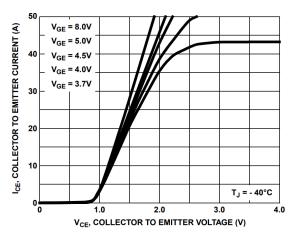


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

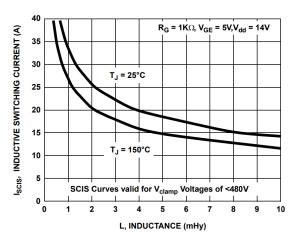


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

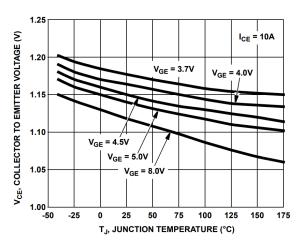


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

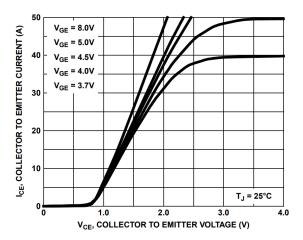


Figure 6. Collector to Emitter On– State Voltage vs. Collector Current

TYPICAL CHARACTERISTICS (Continued)

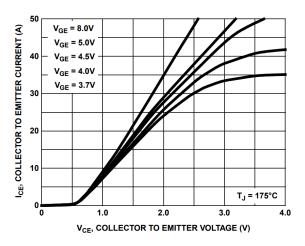


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

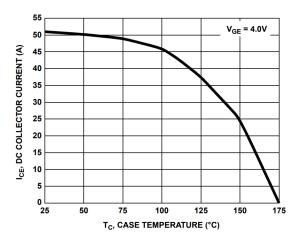


Figure 9. DC Collector Current vs. Case Temperature

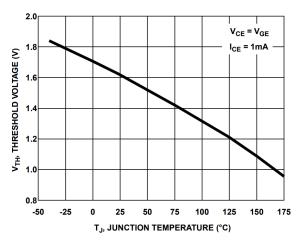


Figure 11. Threshold Voltage vs. Junction Temperature

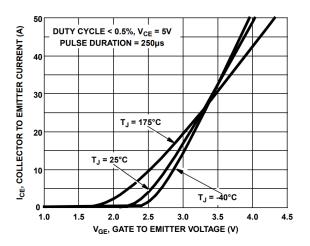


Figure 8. Transfer Characteristics

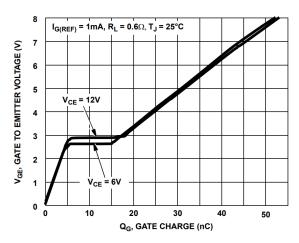


Figure 10. Gate Charge

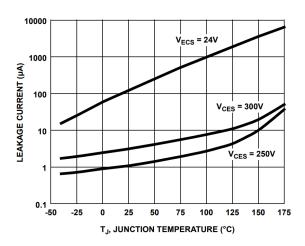
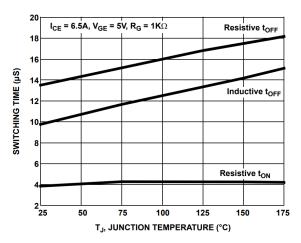


Figure 12. Leakage Current vs. Junction Temperature

TYPICAL CHARACTERISTICS (Continued)



3000 FREQUENCY = 1 MHz

2500 Cles

1500 Coes

1500 Coes

Vce, COLLECTOR TO EMITTER VOLTAGE (V)

Figure 13. Switching Time vs. Junction Temperature

Figure 14. Capacitance vs. Collector to Emitter Voltage

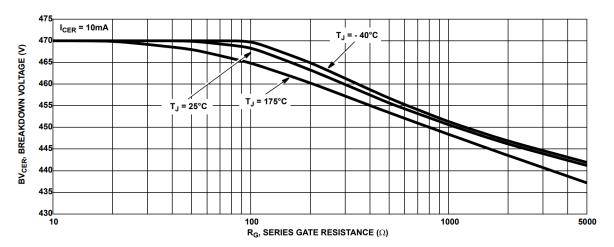


Figure 15. Break down Voltage vs. Series Resistance

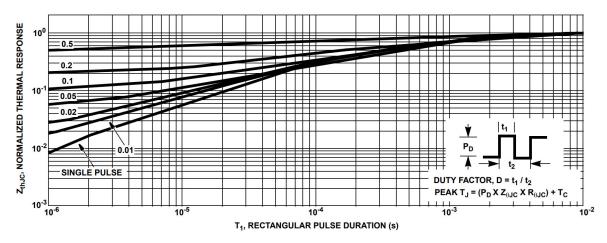


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

TEST CIRCUIT AND WAVEFORMS

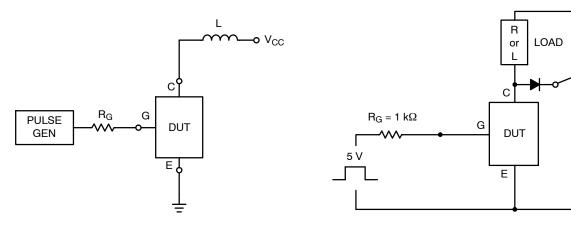


Figure 17. Inductive Switching Test Circuit

Figure 18. $t_{\mbox{\scriptsize ON}}$ and $t_{\mbox{\scriptsize OFF}}$ Switching Test Circuit

 V_{CC}

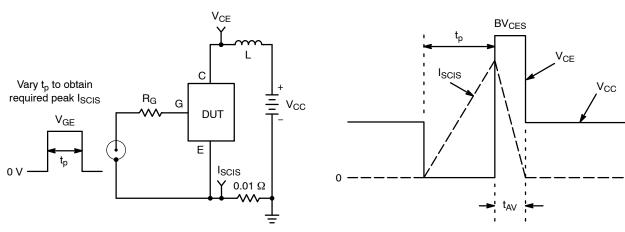


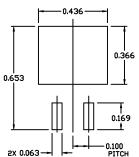
Figure 19. Energy Test Circuit

Figure 20. Energy Waveforms



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DATE 11 MAR 2021



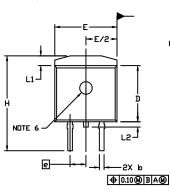
RECOMMENDED MOUNTING FOOTPRINT

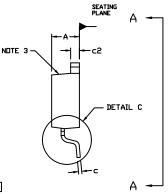
For additional information on our Pb-Free strategy and soldering details, please download the DN Seniconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

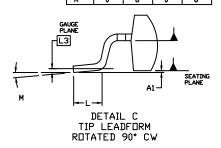
NOTES

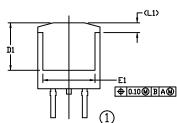
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... DPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIN	ETERS
DIM	MIN.	MAX.	MIN.	MAX.
Α	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
b	0.020	0.039	0.51	0.99
c	0.012	0.029	0.30	0.74
c2	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245		6.22	
e	0.100	0.100 BSC		BSC
Н	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1		0.066		1.68
L5		0.070		1.78
L3	0.010 BSC		0.25	BSC
М	0.	8*	0.	8.

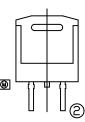


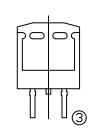


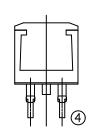




VIEW A-A







VIEW A-A

OPTIONAL CONSTRUCTIONS

GENERIC MARKING DIAGRAMS*

XXXXXX = Specific Device Code A = Assembly Location

WL = Wafer Lot
Y = Year
WW = Work Week
W = Week Code (SSG)
M = Month Code (SSG)
G = Pb-Free Package
AKA = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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98AON56370E

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DESCRIPTION:

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